

Notice of References Cited	Application/Control No. 10/674,999	Applicant(s)/Patent Under Reexamination VOSS-KEHL ET AL.	
	Examiner Christopher M. Keehan	Art Unit 1712	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0005506 A1	01-2004	Nishimura et al.	430/17
	B	US-2004/0163570 A1	08-2004	Vanmaele et al.	106/031.13
	C	US-6,586,104 B2	07-2003	Matsuda et al.	428/447
	D	US-4,894,254	01-1990	Nakayama et al.	427/539
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.